

# POWER MOS IV™

|            |      |      |        |
|------------|------|------|--------|
| APT5085BN  | 500V | 9.5A | 0.85 Ω |
| APT4585BN  | 450V | 9.5A | 0.85 Ω |
| APT501R1BN | 500V | 9.0A | 1.10 Ω |
| APT451R1BN | 450V | 9.0A | 1.10 Ω |

## N - CHANNEL ENHANCEMENT MODE HIGH VOLTAGE POWER MOSFETS

### MAXIMUM RATINGS

All Ratings:  $T_c = 25^\circ\text{C}$  unless otherwise specified.

| Symbol         | Parameter   | APT         |        |         |         | UNIT  |
|----------------|---|-------------|--------|---------|---------|-------|
|                |   | 4585BN      | 5085BN | 451R1BN | 501R1BN |       |
| $V_{DSS}$      | Drain-Source Voltage  | 450         | 500    | 450     | 500     | Volts |
| $I_D$          | Continuous Drain Current  | 9.5         |        | 9.0     |         | Amps  |
| $I_{DM}$       | Pulsed Drain Current <sup>1</sup>   | 38          |        | 36      |         | Amps  |
| $V_{GS}$       | Gate-Source Voltage   | ±30         |        |         |         | Volts |
| $P_D$          | Total Power Dissipation @ $T_c = 25^\circ\text{C}$ ,<br>Derate Above $25^\circ\text{C}$ | 180         |        |         |         | Watts |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range  | - 55 to 150 |        |         |         | °C    |

### STATIC ELECTRICAL CHARACTERISTICS

| Symbol       | Characteristic / Test Conditions / Part Number  | MIN                     | TYP | MAX | UNIT  |               |
|--------------|---|-------------------------|-----|-----|-------|---------------|
| $BV_{DSS}$   | Drain-Source Breakdown Voltage<br>( $V_{GS} = 0V, I_D = 250 \mu\text{A}$ )  | APT5085BN / APT501R1BN  |     | 500 | Volts |               |
|              |   | APT4585BN / APT451R1BN  |     | 450 | Volts |               |
| $I_{DSS}$    | Zero Gate Voltage Drain Current ( $V_{DS} = V_{DSS}, V_{GS} = 0V$ )<br>( $V_{DS} = 0.8 V_{DSS}, V_{GS} = 0V, T_c = 125^\circ\text{C}$ ) |                         |     |     | 250   | $\mu\text{A}$ |
|              |   |                         |     |     | 1000  |               |
| $I_{GSS}$    | Gate-Source Leakage Current ( $V_{GS} = \pm 30V, V_{DS} = 0V$ )   |                         |     |     | ±100  | nA            |
| $I_{D(ON)}$  | On State Drain Current <sup>2</sup><br>( $V_{DS} > I_{D(ON)} \times R_{DS(ON)}$ Max, $V_{GS} = 10V$ )                                   | APT5085BN / APT4585BN   |     | 9.5 | Amps  |               |
|              |   | APT501R1BN / APT451R1BN |     | 9.0 | Amps  |               |
| $V_{GS(TH)}$ | Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 1\text{mA}$ )  | 2                       |     | 4   | Volts |               |
| $R_{DS(ON)}$ | Static Drain-Source On-State Resistance <sup>2</sup><br>( $V_{GS} = 10V, I_D = 0.5 I_{D(Cont.)}$ )                                      | APT5085BN / APT4585BN   |     |     | 0.85  | Ohms          |
|              |   | APT501R1BN / APT451R1BN |     |     | 1.10  | Ohms          |

### THERMAL CHARACTERISTICS

| Symbol          | Characteristic   | MIN | TYP | MAX  | UNIT |
|-----------------|--|-----|-----|------|------|
| $R_{\theta JC}$ | Junction to Case   |     |     | 0.68 | °C/W |
| $R_{\theta JA}$ | Junction to Ambient  |     |     | 40   | °C/W |
| $T_L$           | Max. Lead Temp. for Soldering Conditions: 0.063" from Case for 10 Sec. |     |     | 300  | °C   |

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**DYNAMIC CHARACTERISTICS**

APT5085/4585/501R1/451R1BN

| Symbol     | Characteristic                 | Test Conditions  | MIN | TYP | MAX | UNIT |
|------------|--------------------------------|--|-----|-----|-----|------|
| $C_{iss}$  | Input Capacitance              | $V_{GS} = 0V$<br>$V_{DS} = 25V$<br>$f = 1 MHz$                                   |     | 740 | 950 | pF   |
| $C_{oss}$  | Output Capacitance             |  |     | 167 | 234 | pF   |
| $C_{rss}$  | Reverse Transfer Capacitance   |  |     | 63  | 94  | pF   |
| $Q_g$      | Total Gate Charge <sup>3</sup> | $V_{GS} = 10V, I_D = I_D [Cont.]$<br>$V_{DD} = 0.5 V_{DSS}$                      |     | 33  | 55  | nC   |
| $Q_{gs}$   | Gate-Source Charge             |  |     | 5.6 | 8   | nC   |
| $Q_{gd}$   | Gate-Drain ("Miller") Charge   |  |     | 16  | 24  | nC   |
| $t_d(on)$  | Turn-on Delay Time             | $V_{DD} = 0.5 V_{DSS}$<br>$I_D = I_D [Cont.], V_{GS} = 15V$<br>$R_G = 1.8\Omega$ |     | 10  | 20  | ns   |
| $t_r$      | Rise Time                      |  |     | 14  | 28  | ns   |
| $t_d(off)$ | Turn-off Delay Time            |  |     | 35  | 48  | ns   |
| $t_f$      | Fall Time                      |  |     | 11  | 22  | ns   |

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

| Symbol   | Characteristic / Test Conditions / Part Number                           | MIN                     | TYP | MAX | UNIT    |
|----------|--|-------------------------|-----|-----|---------|
| $I_S$    | Continuous Source Current (Body Diode)                                   | APT5085BN / APT4585BN   |     | 9.5 | Amps    |
|          |  | APT501R1BN / APT451R1BN |     | 9.0 | Amps    |
| $I_{SM}$ | Pulsed Source Current <sup>1</sup> (Body Diode)                          | APT5085BN / APT4585BN   |     | 38  | Amps    |
|          |  | APT501R1BN / APT451R1BN |     | 36  | Amps    |
| $V_{SD}$ | Diode Forward Voltage <sup>2</sup> ( $V_{GS} = 0V, I_S = -I_D [Cont.]$ ) |                         |     | 1.3 | Volts   |
| $t_{rr}$ | Reverse Recovery Time ( $I_S = -I_D [Cont.], di_S/dt = 100A/\mu s$ )     | 108                     | 216 | 432 | ns      |
| $Q_{rr}$ | Reverse Recovery Charge  | 1.2                     | 2.5 | 5.0 | $\mu C$ |

**SAFE OPERATING AREA CHARACTERISTICS**

| Symbol   | Characteristic            | Test Conditions / Part Number                                  | MIN | TYP | MAX | UNIT  |
|----------|---------------------------|--|-----|-----|-----|-------|
| SOA1     | Safe Operating Area       | $V_{DS} = 0.4 V_{DSS}, I_{DS} = P_D / 0.4 V_{DSS}, t = 1 Sec.$ | 180 |     |     | Watts |
| SOA2     | Safe Operating Area       | $I_{DS} = I_D [Cont.], V_{DS} = P_D / I_D [Cont.], t = 1 Sec.$ | 180 |     |     | Watts |
| $I_{LM}$ | Inductive Current Clamped | APT5085BN / APT4585BN  | 38  |     |     | Amps  |
|          |                           | APT501R1BN / APT451R1BN  | 36  |     |     | Amps  |

1.) Repetitive Rating: Pulse width limited by maximum junction temperature. See Transient Thermal Impedance Curve. (Fig.1)

2.) Pulse Test: Pulse width < 380  $\mu s$   
Duty Cycle < 2%  
3.) See MIL-STD-750 Method 3471

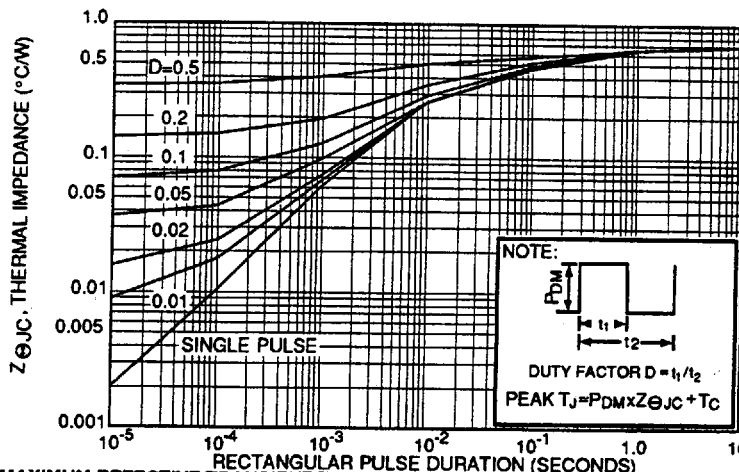


FIGURE 1, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

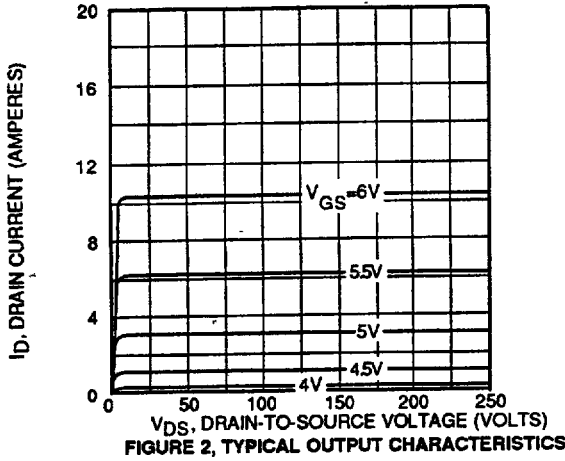


FIGURE 2, TYPICAL OUTPUT CHARACTERISTICS

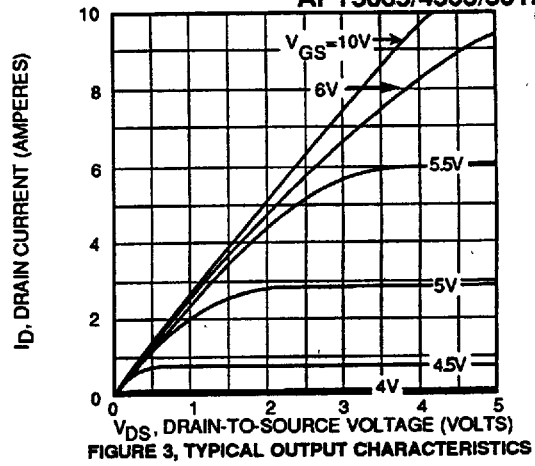


FIGURE 3, TYPICAL OUTPUT CHARACTERISTICS

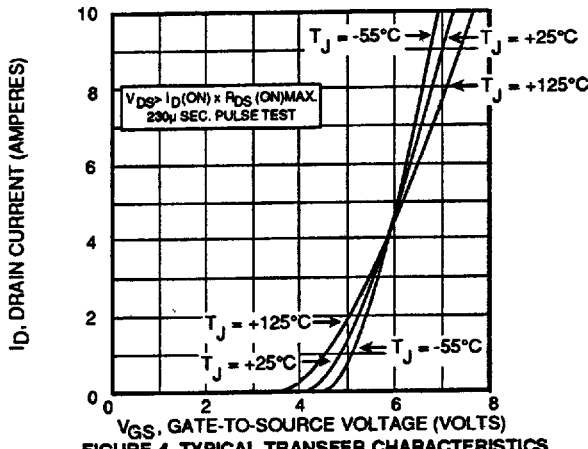


FIGURE 4, TYPICAL TRANSFER CHARACTERISTICS

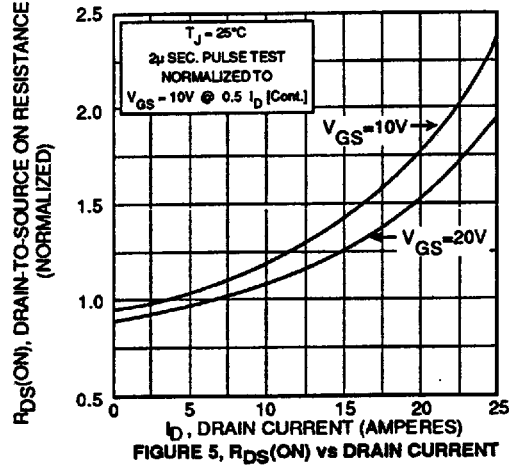


FIGURE 5,  $R_{DS(ON)}$  vs DRAIN CURRENT

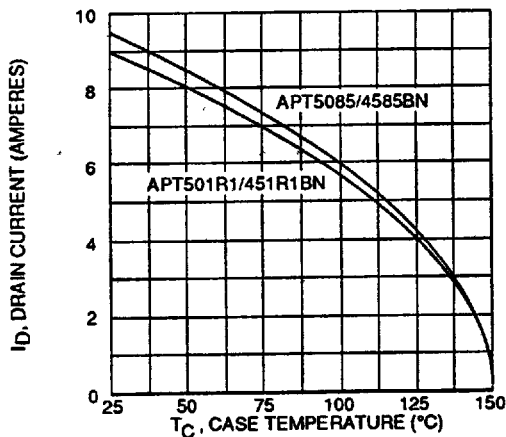


FIGURE 6, MAXIMUM DRAIN CURRENT vs CASE TEMPERATURE

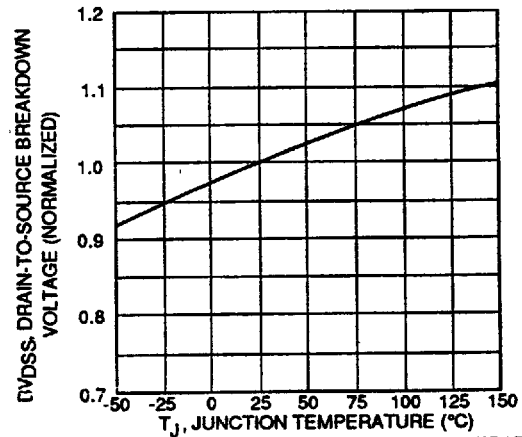


FIGURE 7, BREAKDOWN VOLTAGE vs TEMPERATURE

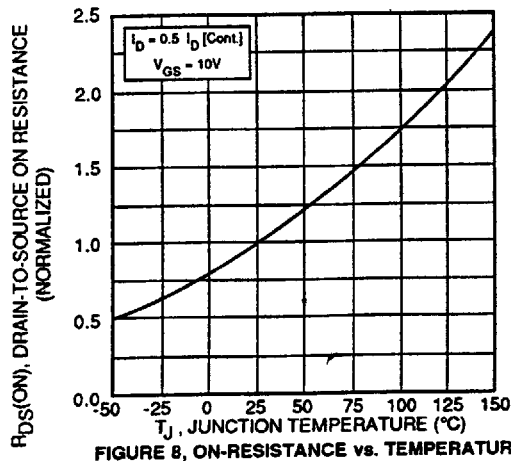


FIGURE 8, ON-RESISTANCE vs. TEMPERATURE

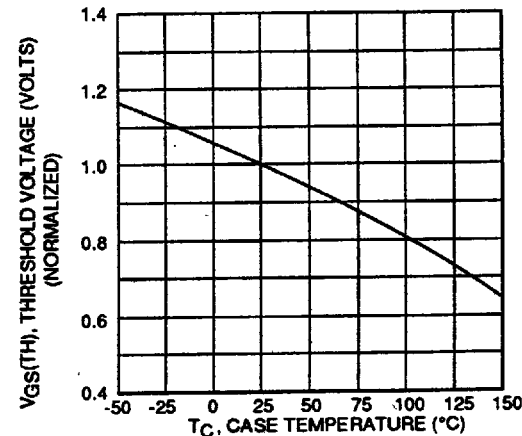


FIGURE 9, THRESHOLD VOLTAGE vs TEMPERATURE

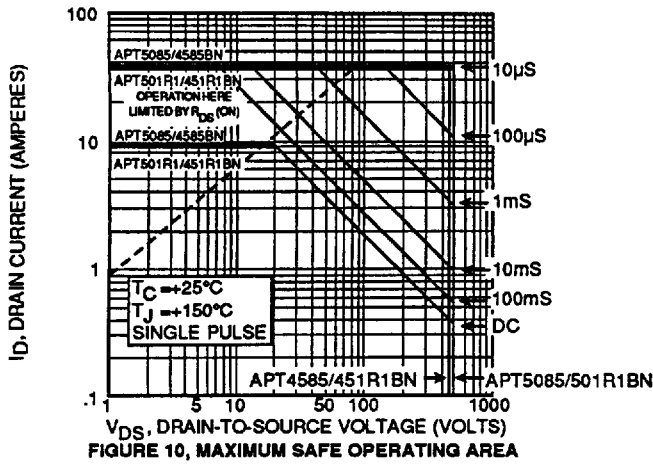


FIGURE 10, MAXIMUM SAFE OPERATING AREA

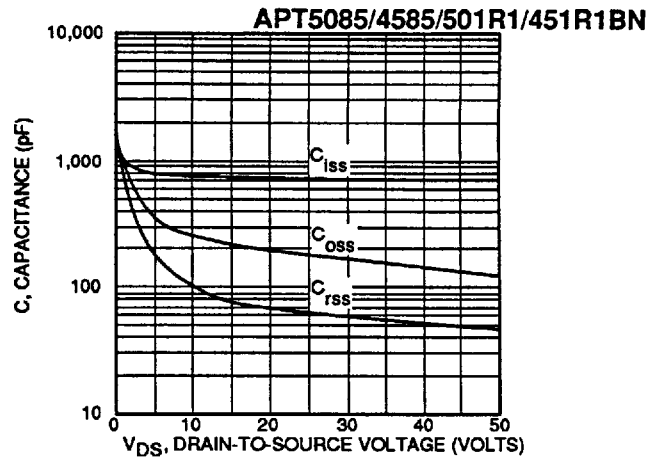


FIGURE 11, TYPICAL CAPACITANCE vs DRAIN-TO-SOURCE VOLTAGE

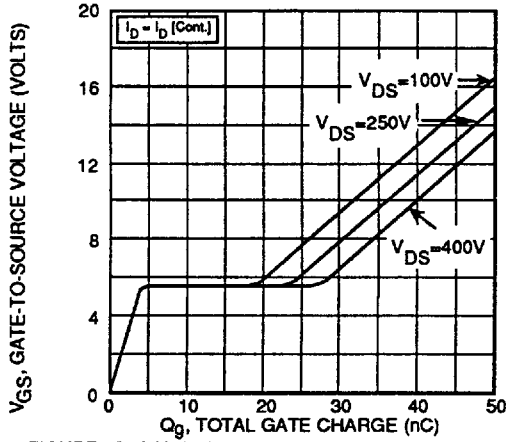


FIGURE 12, GATE CHARGES vs GATE-TO-SOURCE VOLTAGE

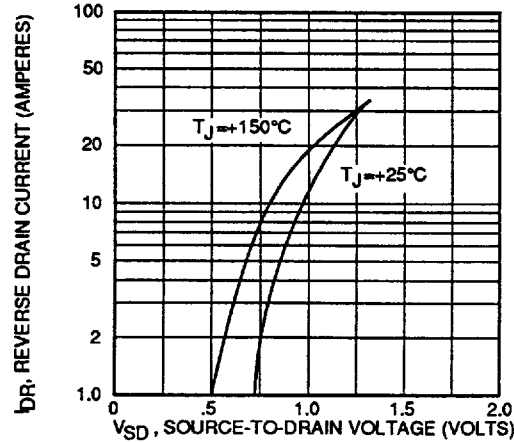
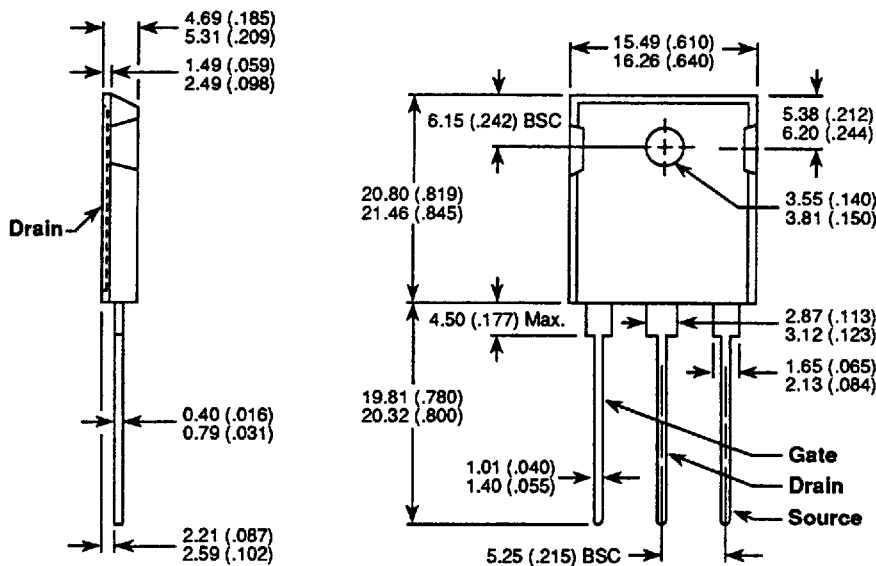


FIGURE 13, TYPICAL SOURCE-DRAIN DIODE FORWARD VOLTAGE

TO-247AD Package Outline



Dimensions in Millimeters and (Inches)